OIP		RMATION DISCLOSURE		4686-118 US Applicant(s) SHEFER et al.		10/	690,114	
APR 2 2 2004				Filing Date 11/13/2002		Group Art Unit		
3	موخ	y		U.S. PATENT DOCUMENTS				
EXAME	DOCUMENT NUMBER		DATE	NAME	CLASS	SUBELASS	FILING DATE	
MITIAL		US 4,217,426	08/12/80	MCCONNELL et al.	525	173	IF APPRO	PRIATE
		US 4,731,243	03/15/88	LINDAUER	424	65		
		US 4,934,542	02/13/90	PARROTTA, Jr et al.	424	66		
		US 4,934,609	06/19/90	LINDAUER	241	3		
		US 5,500,137	03/19/96	BACON et al.	510	102		
		US 5,500,138	03/19/96	BACON et al.	510	102		
		US 5,500,154	03/19/96	BACON et al.	510	102		
		US 5,531,910	07/02/96	SEVERNS et al.	510	102		
		US 5,540,853	07/30/96	TRINH et al.	510	101		
		US 5,562,641	10/08/96	WAITE et al.	510	519		
		US 5,652,206	07/29/97	BACON et al.	510	101		
•				FOREIGN PATENT DOCUMENTS				
	REF	GB 1 460 646 10/15/1974		COUNTRY	CLASS	SUBCLASS	Transl YES	NO NO
				Great Britain				
		WO 92/05767	04/16/1992	PCT				
		WO 97/06777	02/27/1997	7/1997 PCT				
				-				
						ate, Pertinent Pa		
		Contents, Preface) Marc	h 1, 1988.	ary A. (Editory), "Flavor Encapsulat				
		Sellassie, G.I., (Editor), Sciences, Vol. 65, 1994	'Preparation of	Micropellets by Spray Congealing", p	op. 17-34, Dro	ugs and the Ph	armaceutic	al
EXAMINER /Cong Lac Huynh/			DATE CONSIDERED 06/29/2006					
		al if citation considered, whether o clude copy of this form with next c		conformance with MPEP Section 609; Diapplicant.	raw line throu	gh citation if not	in conforms	nce and
				POGA (PIC) (FIV				

					Docket Number (Optional) 4686–118 US	• •	plication Number 10/690,114		
INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)					Applicant(s) SHEFER et al.				
APR 2 2	200.	8	//		Filing Date	To	Group Art Unit		
2 2014 14					11/13/2002		1616		
3 PADE	wer o	<u> </u>		U.S. PAT	ENT DOCUMENTS				
EXAMINER	REP	DOCUMENT NUMBER	DATE		NAME	CLASS	SUBCLASS	FILING IF APPRO	
		US 5,830,835	11/10/98	TRINH et al.		424	401		
		US 5,833,999	11/10/98	TRINH et al.		424	401		
		US 5,849,310	12/15/98	TRINH et al.		424	401		
		US 5,919,752	07/06/99	MORELLL of al.		512	1		
		US 6,086,903	07/11/00	PRINH et al.		424	401		
		US 6,147,037	11/14/00	GARDLIK et al.		510	107		
		US 6,184,188	02/06/01	SEVERNS et al.		510	101		
		US 6,447,791	09/10/02	KOWA	LIK et al.	424	401		
								•	
,									
				FOREIG	N PATENT DOCUMENTS	•			
	REF	DOCUMENT NUMBER DATE		COUNTRY		CLASS	SUBCLASS	Transia YES	ntion NO
	-								
*									
				OTHER I	OCUMENTS (Including	Author, Title, D	Pate, Pertinent Pa	ges, Etc.)	
				-					
					•				
EXAMINE	R	/Cong Lac Huynh/			DATE CONSIDERED	06/29/20	06		
		al if citation considered, whether clude copy of this form with next			ce with MPEP Section 609; D	raw line throu	gh citation if not	in conforma	nce and
ot considered. Include copy of this form with next communication to applicant.									

_					Docket Number (Optional) 4686-118 US		Application Number 10/690,114			
101	INF 6	RMATION DISCLOSURI	E CITATION		Applicant(s) Wrong name					
(APR 1 9 2004 E)				Filing Date 1 1/13/200		Group Art Unit				
FEE		N. S.	U	.S. PATENT DOCUMENTS						
EXAMENER INITIAL	REP	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	Piling date If appropriate			
•										
· •										
								:		
						<u> </u>				
	<u></u>		F(OREIGN PATENT DOCUMENTS	<u>l</u>	<u> </u>	<u>! </u>			
	REF	DOCUMENT NUMBER	DATE	COUNTRY CLASS		SUBCLASS	Translation YES	МО		
•				-						
,										
-										
					g Author, Title,	Date, Pertinent Pa	iges, Etc.)			
		"Goometics Science and Preparations; Photodys	Technology" Segari namic Considerations	n et al., Chapter VIII, Pages 18	9-et sequ-Klai	rmann, Emil G.	"Suntan-			
<u> </u>								1		
XAMINE	R	/Cong Lac Huynh/		DATE CONSIDERED	07/03/20	06				
XAMINEI ot consider	R: Initia	l if citation considered, whether lude copy of this form with next	or not citation is in con	formance with MPEP Section 609	Draw line thro	ugh citation if not	in conformance	and		
										